

< High Voltage Insulated Gate Bipolar Transistor : HVIGBT >

# CM1200DC-34S1

HIGH POWER SWITCHING USE  
INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

## CM1200DC-34S1



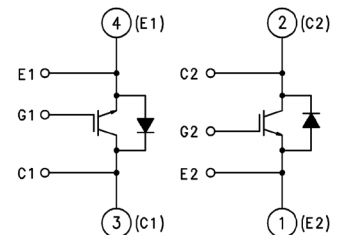
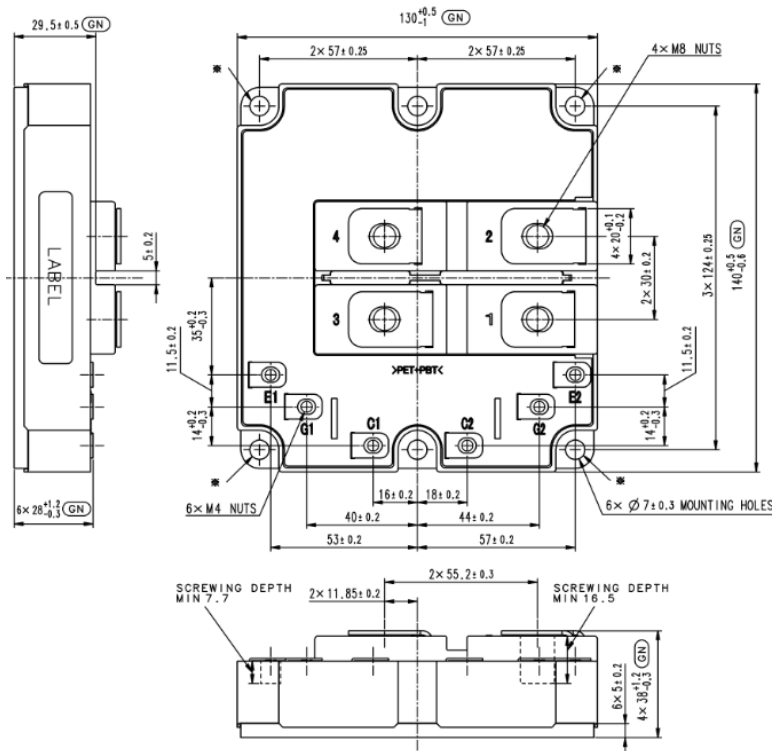
- $I_C$ ..... 1200A
- $V_{CES}$ ..... 1700V
- 2-elements in a Pack
- Insulated Type
- CSTBT™(III) / RFC Diode
- AISiC Baseplate

## APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers

## OUTLINE DRAWING & CIRCUIT DIAGRAM

Dimensions in mm



CIRCUIT DIAGRAM

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**MAXIMUM RATINGS**

Item	Symbol	Conditions		Ratings	Unit
Collector-emitter voltage Gate-emitter short-circuited	$V_{CES}$	$V_{GE} = 0 \text{ V}$	$T_J = -40 \sim +150 \text{ }^{\circ}\text{C}$	1700	V
			$T_J = -50 \text{ }^{\circ}\text{C}$	1650	
Gate-emitter voltage Collector-emitter short-circuited	$V_{GES}$	$V_{CE} = 0 \text{ V}$	$T_J = 25 \text{ }^{\circ}\text{C}$	$\pm 20$	V
Collector current	$I_C$	$T_c = 90 \text{ }^{\circ}\text{C}$ , DC		1200	A
(Repetitive peak) Collector current	$I_{CRM}$	Pulse (Note 1)		2400	A
Emitter current	$I_E$	DC (Note 2)		1200	A
(Repetitive peak) Emitter current	$I_{ERM}$	Pulse (Note 1, 2)		2400	A
Total power dissipation	$P_{tot}$	$T_c = 25 \text{ }^{\circ}\text{C}$ , IGBT part(Note 3)		6750	W
Isolation voltage	$V_{isol}$	Charged part to the baseplate RMS sinusoidal, 60Hz 1min		6000	$V_{rms}$
Partial discharge charge	$Q_{pd}$	Charged part to the baseplate, RMS sinusoidal, 60 Hz $V_1 = 3500 \text{ V}$ , $V_2 = 2600 \text{ V}$ , (acc. to IEC 61287-1)		10	pC
Junction temperature	$T_J$	Maximum temperature range in off-state or on-state(non-switching)		$-50 \sim +150$	$^{\circ}\text{C}$
Storage temperature	$T_{stg}$	Maximum case temperature range in off-state		$-50 \sim +150$	$^{\circ}\text{C}$
Operating junction temperature	$T_{jop}$	Maximum junction temperature range for switching operation		$-50 \sim +150$	$^{\circ}\text{C}$
Turn-off collector current	$I_{C(off)}$	$V_{GE} = \pm 15 \text{ V}$ , $L_s = 70 \text{ nH}$ , $R_{G(off)} = 3.3 \Omega$ , $V_{CC} \leq 1200 \text{ V}$ , $V_{CE} \leq 1700 \text{ V}$	$T_J = 150 \text{ }^{\circ}\text{C}$	2400	A
Short-circuit withstand pulse duration	$t_{pSC}$	$V_{GE} = \pm 15 \text{ V}$ , $L_s \leq 70 \text{ nH}$ , $R_{G(off)} = 3.3 \Omega$ , $V_{CC} \leq 1200 \text{ V}$ , $V_{CE} \leq 1700 \text{ V}$	$T_J = 150 \text{ }^{\circ}\text{C}$	10	$\mu\text{s}$
Reverse recovery power dissipation	$P_{rr}$	$I_E = 2400 \text{ A}$ , $L_s = 70 \text{ nH}$ , $V_{CC} \leq 1200 \text{ V}$ , $di/dt \leq 8000 \text{ A/us}$ , $V_{CE} \leq 1700 \text{ V}$	$T_J = 150 \text{ }^{\circ}\text{C}$	1.1	MW

**ELECTRICAL CHARACTERISTICS**

Item	Symbol	Conditions		Limits			Unit
				Min.	Typ.	Max.	
Collector-emitter cut-off current Gate-emitter short-circuited	I <sub>CES</sub>	V <sub>CE</sub> = 1700 V , V <sub>GE</sub> = 0 V	T <sub>J</sub> = 25 °C	-	-	4.0	mA
			T <sub>J</sub> = 125 °C	-	1.8	-	mA
			T <sub>J</sub> = 150 °C	-	-	40.0	mA
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	V <sub>CE</sub> = 10 V , I <sub>C</sub> = 120mA	T <sub>J</sub> = 25 °C	5.40	6.00	6.60	V
Gate leakage current Collector-emitter short-circuited	I <sub>GES</sub>	V <sub>CE</sub> = 0 V , V <sub>GE</sub> = ±20 V	T <sub>J</sub> = 25 °C	-0.5	-	0.5	µA
Gate charge	Q <sub>G</sub>	V <sub>CC</sub> = 850 V , I <sub>C</sub> = 1200 A , V <sub>GE</sub> = ±15 V	T <sub>J</sub> = 25 °C	-	12.0	-	µC
Input capacitance	C <sub>ies</sub>	V <sub>CE</sub> = 10 V , V <sub>GE</sub> = 0 V , f = 100kHz	T <sub>J</sub> = 25 °C	-	216	-	nF
Output capacitance	C <sub>oes</sub>	V <sub>CE</sub> = 10 V , V <sub>GE</sub> = 0 V , f = 100kHz	T <sub>J</sub> = 25 °C	-	8.0	-	nF
Reverse transfer capacitance	C <sub>res</sub>	V <sub>CE</sub> = 10 V , V <sub>GE</sub> = 0 V , f = 100kHz	T <sub>J</sub> = 25 °C	-	1.6	-	nF
Collector-emitter saturation voltage	V <sub>CEsat</sub>	I <sub>C</sub> = 1200 A , V <sub>GE</sub> = +15 V(Note 4)	T <sub>J</sub> = 25 °C	-	1.95	-	V
			T <sub>J</sub> = 125 °C	-	2.25	-	V
			T <sub>J</sub> = 150 °C	-	2.30	2.80	V
Emitter-collector voltage	V <sub>EC</sub>	I <sub>E</sub> = 1200 A , V <sub>GE</sub> = 0 V(Note 2, 4)	T <sub>J</sub> = 25 °C	-	2.20	-	V
			T <sub>J</sub> = 125 °C	-	2.35	-	V
			T <sub>J</sub> = 150 °C	-	2.35	2.85	V
Turn-on delay time	t <sub>d(on)</sub>	V <sub>CC</sub> = 850 V , I <sub>C</sub> = 1200 A , V <sub>GE</sub> = ±15 V , L <sub>s</sub> = 70 nH R <sub>G(on)</sub> = 1.3 Ω , R <sub>G(off)</sub> = 3.3 Ω Inductive load(Note 5)	T <sub>J</sub> = 150 °C	-	-	1.10	µs
Rise time	t <sub>r</sub>		T <sub>J</sub> = 150 °C	-	-	0.41	µs
Turn-on (switching) energy per pulse 10% integral	E <sub>on(10%)</sub>		T <sub>J</sub> = 25 °C	-	265	-	mJ
			T <sub>J</sub> = 125 °C	-	350	-	mJ
			T <sub>J</sub> = 150 °C	-	355	-	mJ
Turn-on (switching) energy per pulse	E <sub>on</sub>		T <sub>J</sub> = 25 °C	-	290	-	mJ
			T <sub>J</sub> = 125 °C	-	370	-	mJ
			T <sub>J</sub> = 150 °C	-	380	-	mJ

**ELECTRICAL CHARACTERISTICS**

Item	Symbol	Conditions		Limits			Unit
				Min.	Typ.	Max.	
Reverse recovery time	$t_{rr}$	$V_{CC} = 850 \text{ V}$ , $I_E = 1200 \text{ A}$ , $V_{GE} = \pm 15 \text{ V}$ , $L_s = 70 \text{ nH}$ $R_{G(on)} = 1.3 \Omega$ , $R_{G(off)} = 3.3 \Omega$ Inductive load(Note 2, 5, 6)	$T_j = 25 \text{ }^{\circ}\text{C}$	-	0.30	-	$\mu\text{s}$
			$T_j = 125 \text{ }^{\circ}\text{C}$	-	0.40	-	$\mu\text{s}$
			$T_j = 150 \text{ }^{\circ}\text{C}$	-	0.45	-	$\mu\text{s}$
Reverse recovery current	$I_{rr}$		$T_j = 25 \text{ }^{\circ}\text{C}$	-	735	-	A
			$T_j = 125 \text{ }^{\circ}\text{C}$	-	865	-	A
			$T_j = 150 \text{ }^{\circ}\text{C}$	-	875	-	A
Reverse recovery charge 10% integral	$Q_{rr(10\%)}$		$T_j = 25 \text{ }^{\circ}\text{C}$	-	190	-	$\mu\text{C}$
			$T_j = 125 \text{ }^{\circ}\text{C}$	-	295	-	$\mu\text{C}$
			$T_j = 150 \text{ }^{\circ}\text{C}$	-	365	-	$\mu\text{C}$
Reverse recovered charge	$Q_{rr}$		$T_j = 25 \text{ }^{\circ}\text{C}$	-	265	-	$\mu\text{C}$
			$T_j = 125 \text{ }^{\circ}\text{C}$	-	340	-	$\mu\text{C}$
			$T_j = 150 \text{ }^{\circ}\text{C}$	-	420	-	$\mu\text{C}$
Reverse recovery energy per pulse 10% integral	$E_{rec(10\%)}$		$T_j = 25 \text{ }^{\circ}\text{C}$	-	90	-	mJ
			$T_j = 125 \text{ }^{\circ}\text{C}$	-	150	-	mJ
			$T_j = 150 \text{ }^{\circ}\text{C}$	-	195	-	mJ
Reverse recovery energy	$E_{rec}$		$T_j = 25 \text{ }^{\circ}\text{C}$	-	150	-	mJ
			$T_j = 125 \text{ }^{\circ}\text{C}$	-	190	-	mJ
			$T_j = 150 \text{ }^{\circ}\text{C}$	-	240	-	mJ
Turn-off delay time	$t_{d(off)}$	$V_{CC} = 850 \text{ V}$ , $I_C = 1200 \text{ A}$ , $V_{GE} = \pm 15 \text{ V}$ , $L_s = 70 \text{ nH}$ $R_{G(on)} = 1.3 \Omega$ , $R_{G(off)} = 3.3 \Omega$ Inductive load(Note 5)	$T_j = 25 \text{ }^{\circ}\text{C}$	-	1.20	-	$\mu\text{s}$
			$T_j = 125 \text{ }^{\circ}\text{C}$	-	1.30	-	$\mu\text{s}$
			$T_j = 150 \text{ }^{\circ}\text{C}$	-	1.32	-	$\mu\text{s}$
Fall time	$t_f$		$T_j = 25 \text{ }^{\circ}\text{C}$	-	0.12	-	$\mu\text{s}$
			$T_j = 125 \text{ }^{\circ}\text{C}$	-	0.15	-	$\mu\text{s}$
			$T_j = 150 \text{ }^{\circ}\text{C}$	-	0.17	-	$\mu\text{s}$
Turn-off (switching) energy per pulse 10% integral	$E_{off(10\%)}$		$T_j = 25 \text{ }^{\circ}\text{C}$	-	200	-	mJ
			$T_j = 125 \text{ }^{\circ}\text{C}$	-	280	-	mJ
			$T_j = 150 \text{ }^{\circ}\text{C}$	-	310	-	mJ
Turn-off (switching) energy per pulse	$E_{off}$		$T_j = 25 \text{ }^{\circ}\text{C}$	-	260	-	mJ
			$T_j = 125 \text{ }^{\circ}\text{C}$	-	360	-	mJ
			$T_j = 150 \text{ }^{\circ}\text{C}$	-	400	-	mJ

Note1. Pulse width and repetition rate should be such that junction temperature ( $T_j$ ) does not exceed  $T_{jopmax}$  rating.

Note2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD).

Note3. Junction temperature ( $T_j$ ) should not exceed  $T_{jmax}$  rating ( $150^\circ\text{C}$ ).

Note4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

Note5. The integration range of switching energies( $E_{on(10\%)}$ ,  $E_{rec(10\%)}$ ,  $E_{off(10\%)}$ ) is from  $10\%V_{CE}$  to  $10\%I_C(10\%I_E)$ .

Note6. The integration range of reverse recovery charge( $Q_{rr(10\%)}$ ) is from  $I_E = 0\text{A}$  to  $10\%I_E$ .

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**THERMAL CHARACTERISTICS**

Item	Symbol	Conditions	Limits			Unit
			Min.	Typ.	Max.	
Thermal resistance junction to case, IGBT	$R_{th(j-c)Q}$	Junction to Case, IGBT part, 1/2 module	-	-	18.5	K/kW
Thermal resistance Junction to case, DIODE	$R_{th(j-c)D}$	Junction to Case, FWDi part, 1/2 module	-	-	38.0	K/kW
Contact thermal resistance case to heatsink	$R_{th(c-s)}$	Case to heat sink, 1/2 module $\lambda_{grease} = 1 \text{ W/m}\cdot\text{k}$ , $D_{(c-s)} = 100 \text{ }\mu\text{m}$	-	16.0	-	K/kW

**MECHANICAL CHARACTERISTICS**

Item	Symbol	Conditions	Limits			Unit
			Min.	Typ.	Max.	
Mounting torque	$M_t$	Main terminals screw: M8	7.0	-	20.0	N·m
Mounting torque		Mounting screw: M6	3.0	-	6.0	N·m
Mounting torque		Auxiliary terminals screw: M4	1.0	-	3.0	N·m
Mass	$m$	-	-	0.8	-	kg
Comparative tracking index	CTI	-	600	-	-	-
Clearance distance in air	$d_a$	Collector main terminal - Emitter main terminal Terminal - Baseplate	9.5	-	-	mm
Creepage distance along surface	$d_s$	Collector main terminal - Emitter main terminal	15.0	-	-	mm
Creepage distance along surface	$d_s$	Terminal - Baseplate	15.0	-	-	mm
Internal inductance (C-E)	$L_{P(C-E)}$	1/2 module, IGBT part, $T_c=25^\circ\text{C}$	-	22	-	nH
Internal lead resistance, CC'-EE'	$R_{CC'+EE'}$	1/2 module, IGBT part, $T_c=25^\circ\text{C}$	-	0.16	-	mΩ

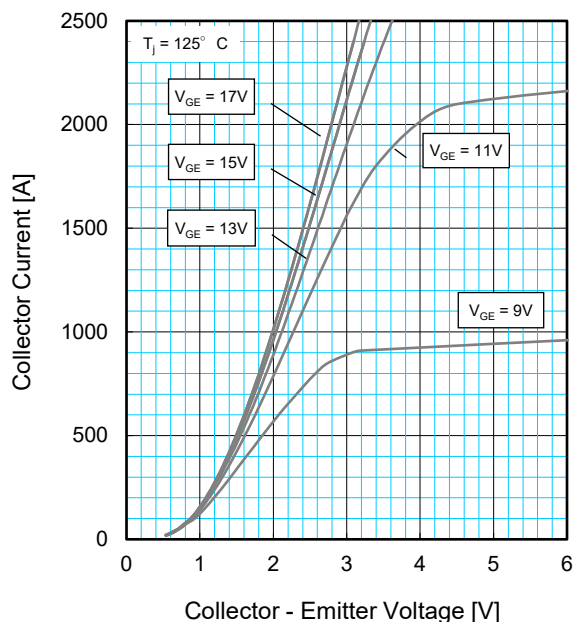
# CM1200DC-34S1

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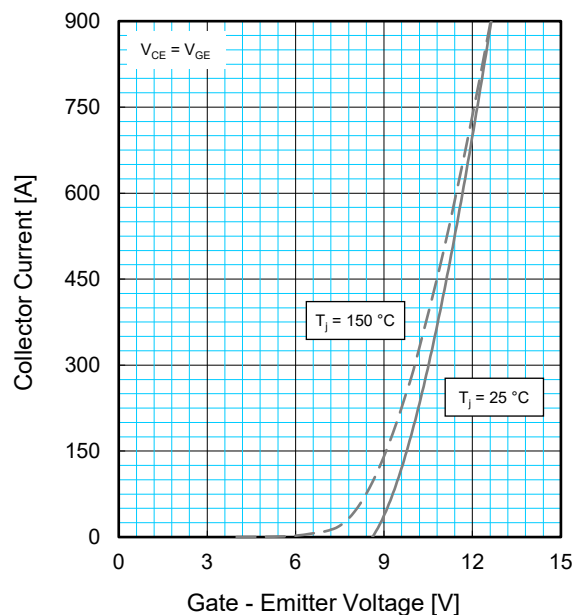
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## PERFORMANCE CURVES

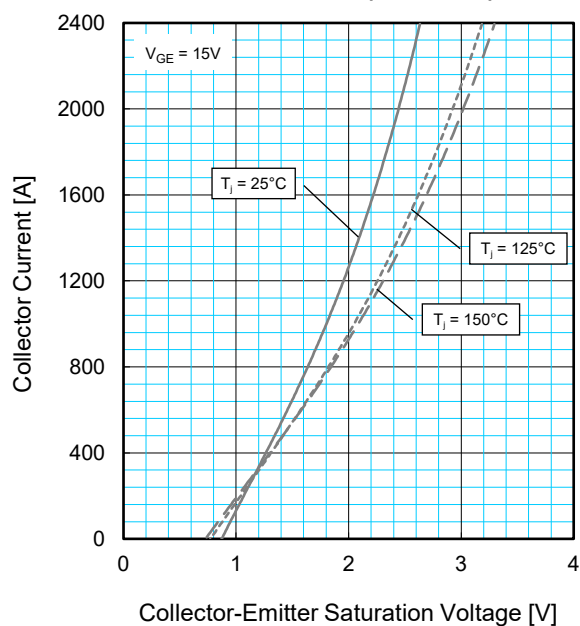
OUTPUT CHARACTERISTICS  
(TYPICAL)



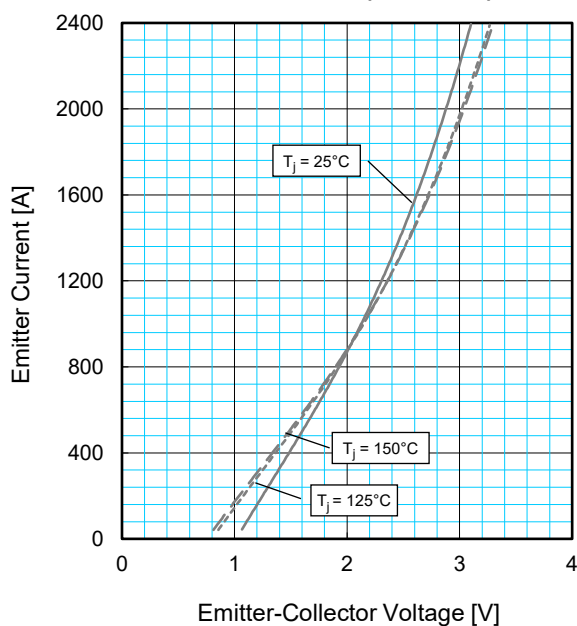
TRANSFER CHARACTERISTICS  
(TYPICAL)



COLLECTOR-EMITTER SATURATION VOLTAGE  
CHARACTERISTICS (TYPICAL)



FREE-WHEEL DIODE FORWARD  
CHARACTERISTICS (TYPICAL)



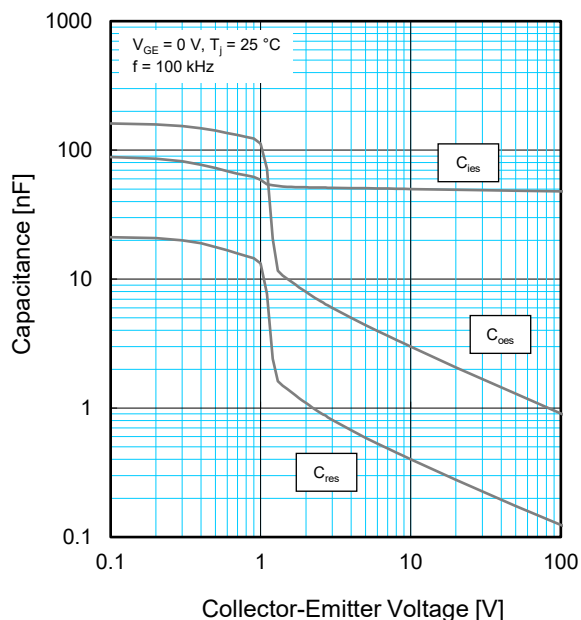
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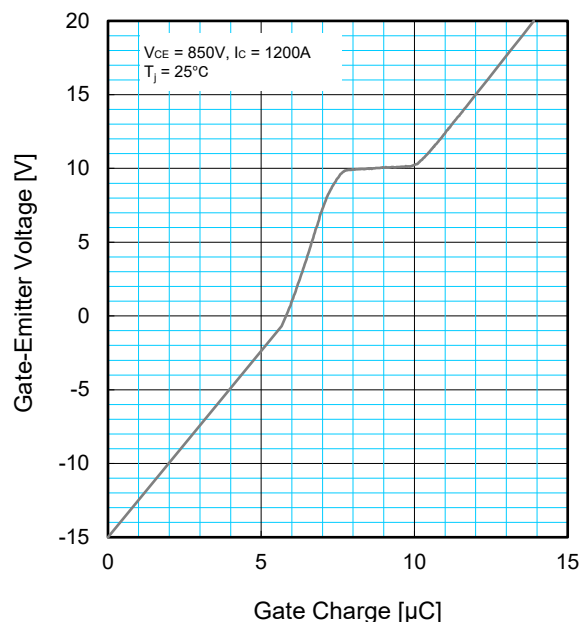
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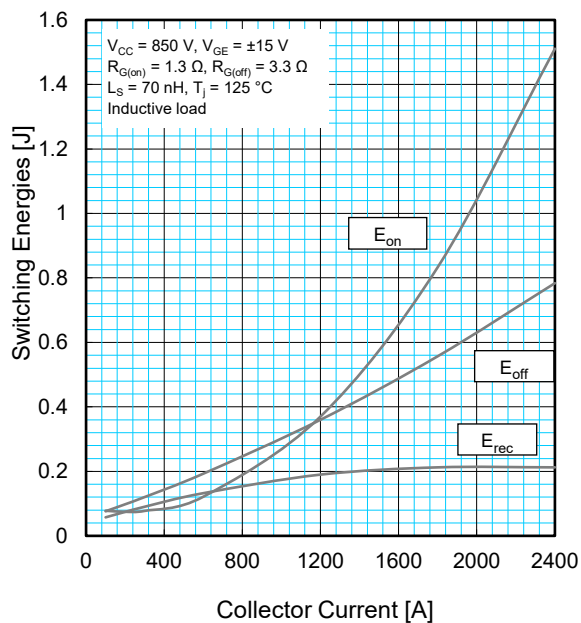
**CAPACITANCE CHARACTERISTICS  
(TYPICAL)**



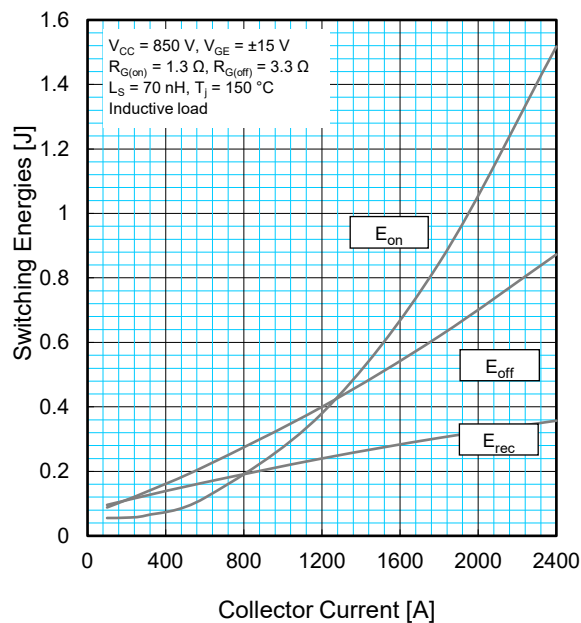
**GATE CHARGE CHARACTERISTICS  
(TYPICAL)**



**HALF-BRIDGE SWITCHING ENERGY  
CHARACTERISTICS (TYPICAL)**



**HALF-BRIDGE SWITCHING ENERGY  
CHARACTERISTICS (TYPICAL)**



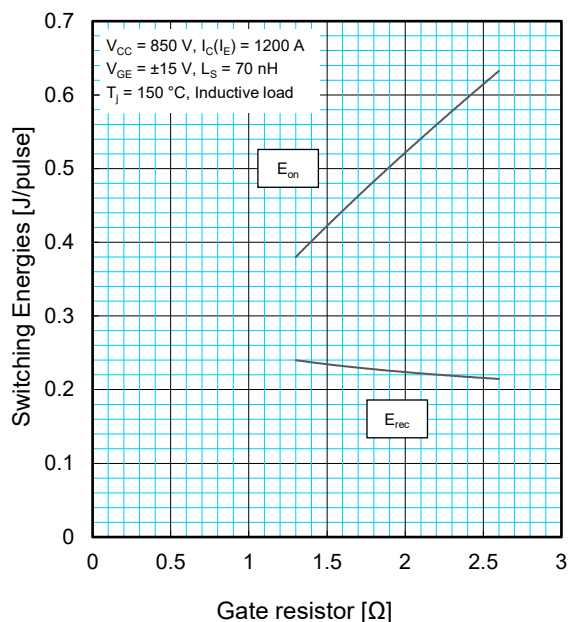
# CM1200DC-34S1

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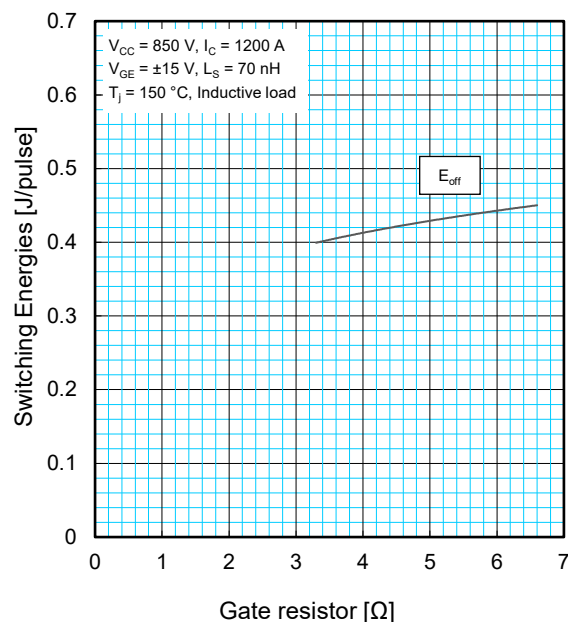
5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

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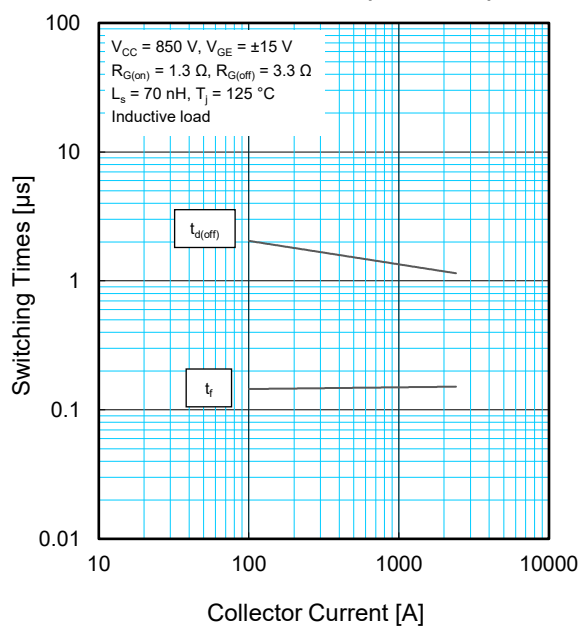
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



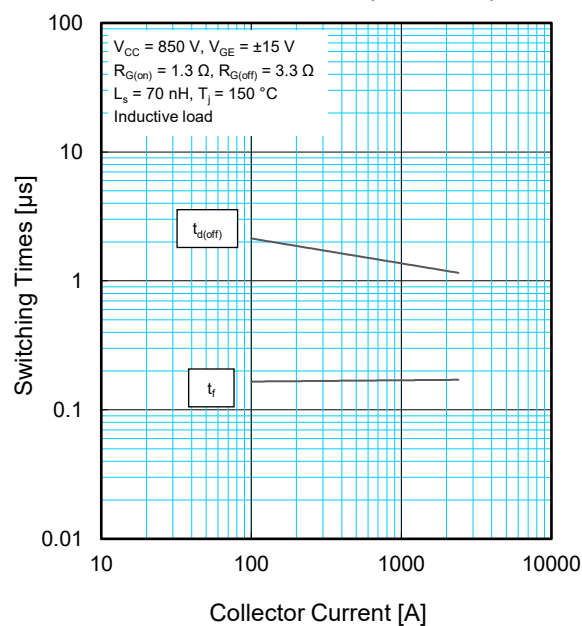
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



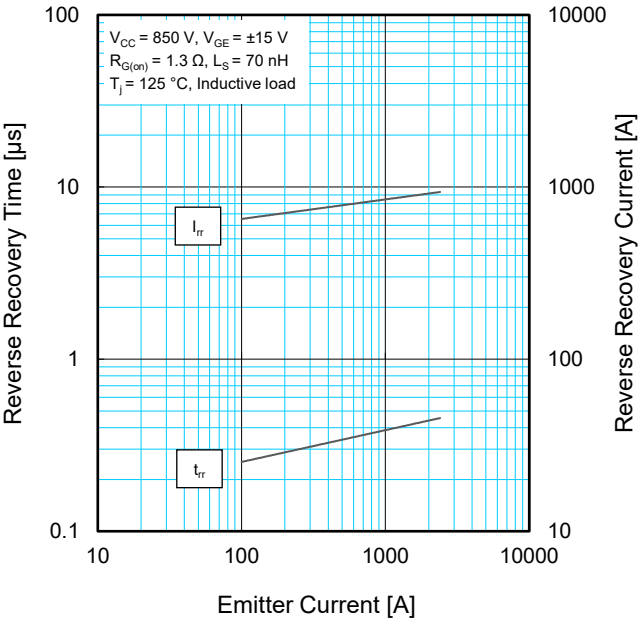
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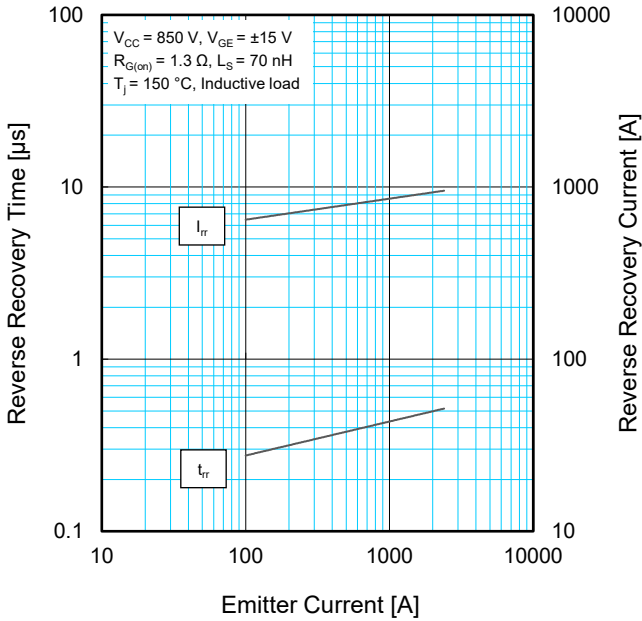
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PERFORMANCE CURVES

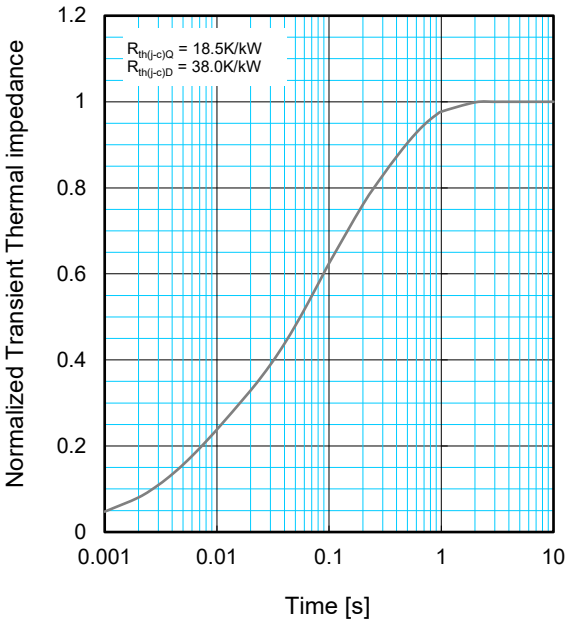
FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i \left\{ 1 - \exp\left(-\frac{t}{\tau_i}\right) \right\}$$

	1	2	3	4
$R_i$ [K/kW] :	0.0096	0.1893	0.4044	0.3967
$\tau_i$ [sec.] :	0.0001	0.0058	0.0602	0.3512



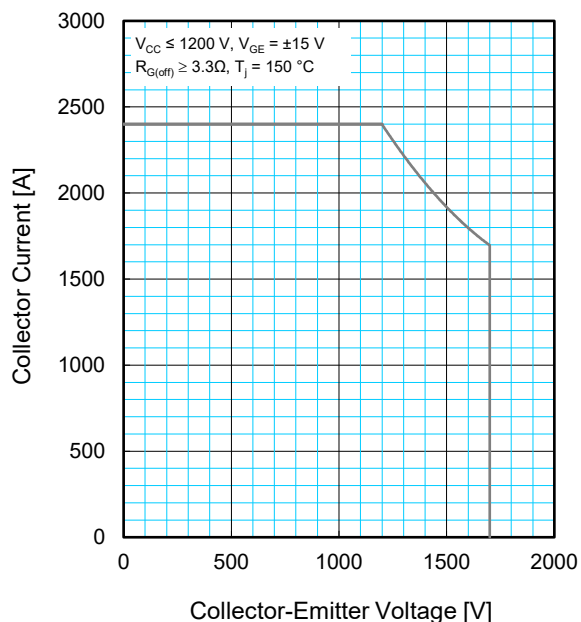
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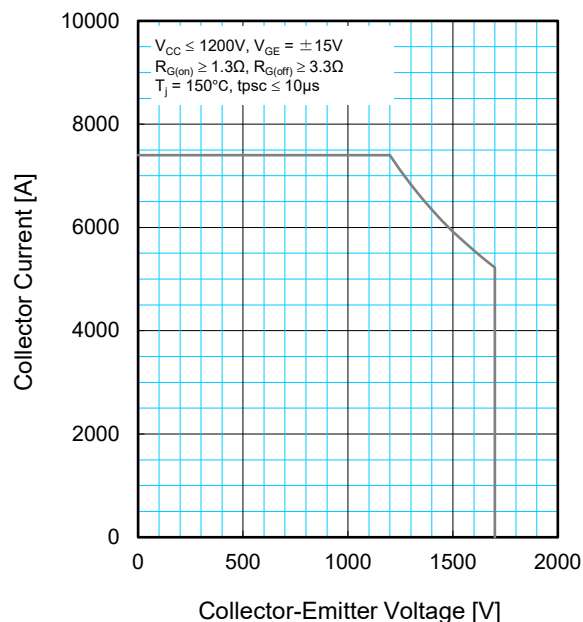
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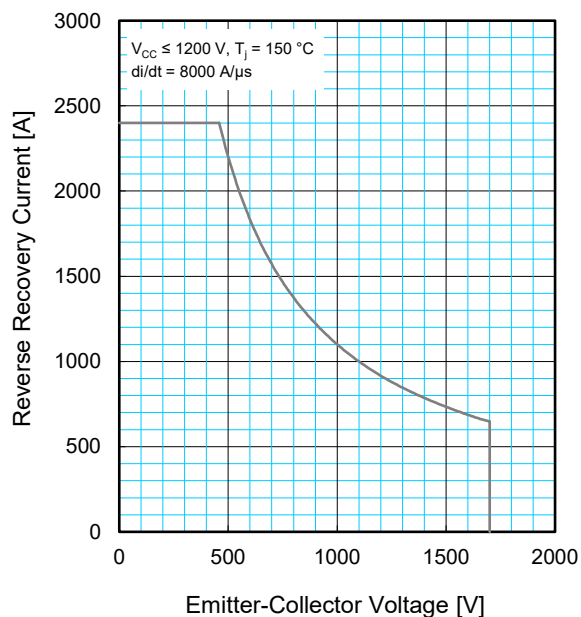
**REVERSE BIAS SAFE OPERATING AREA (RBSOA)**



**SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)**



**FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)**



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